

# OptiMOS<sup>™</sup> Small-Signal-Transistor

#### **Features**

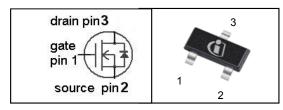
- N-channel
- · Enhancement mode
- Logic level
- Avalanche rated
- · fast switching
- Pb-free lead-plating; RoHS compliant
- Halogen-free according to IEC61249-2-21



#### **Product Summary**

V <sub>DS</sub>	60	V	
R <sub>DS(on),max</sub>	3	Ω	
	V <sub>GS</sub> =4.5 V	4	
I <sub>D</sub>		0.3	Α





Туре	Package	Tape and Reel Information	Marking	HalogenFree	Packing	
2N7002	PG-SOT-23	H6327: 3000 pcs/reel	72s	Yes	Non Dry	

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	ID	T <sub>A</sub> =25 °C	0.30	А
		T <sub>A</sub> =70 °C	0.24	
Pulsed drain current	I <sub>D,pulse</sub>	T <sub>A</sub> =25 °C	1.2	
Avalanche energy, single pulse	E <sub>AS</sub>	$I_{\rm D}$ =0.3 A, $R_{\rm GS}$ =25 $\Omega$	1.3	mJ
Reverse diode dv/dt	dv/dt	$I_{\rm D}$ =0.3 A, $V_{\rm DS}$ =48 V, d <i>i</i> /d <i>t</i> =200 A/ $\mu$ s, $T_{\rm j,max}$ =150 °C	6	kV/μs
Gate source voltage	$V_{GS}$		±20	V
ESD class		JESD22-A114 (HBM)	class 0 (<250V)	
Power dissipation	P <sub>tot</sub> (2)	T <sub>A</sub> =25 °C	0.5	W
Operating and storage temperature	$T_{\rm j},T_{\rm stg}$		-55 150	°C
IEC climatic category; DIN IEC 68-1			55/150/56	

<sup>(1)</sup> J-STD20 and JESD22



Parameter	Symbol	Conditions	Values		Unit	
			min.	typ.	max.	
Thermal characteristics						
Thermal resistance, junction - minimal footprint <sup>(2)</sup>	$R_{thJA}$		-	-	250	K/W

## **Electrical characteristics,** at $T_j$ =25 °C, unless otherwise specified

#### Static characteristics

Drain-source breakdown voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> =250 μA	60	-	-	V
Gate threshold voltage	$V_{GS(th)}$	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250 μA	1.5	2.1	2.5	
Drain-source leakage current	I <sub>D (off)</sub>	V <sub>DS</sub> =60 V, V <sub>GS</sub> =0 V, T <sub>j</sub> =25 °C	ı	-	0.1	μΑ
		V <sub>DS</sub> =60 V, V <sub>GS</sub> =0 V, T <sub>j</sub> =150 °C	-	-	5	
Gate-source leakage current	I <sub>GSS</sub>	V <sub>GS</sub> =20 V, V <sub>DS</sub> =0 V	-	1	10	nA
Drain-source on-state resistance	$R_{ ext{DS(on)}}$	V <sub>GS</sub> =4.5 V, I <sub>D</sub> =0.25 A	-	2.0	4	Ω
		V <sub>GS</sub> =10 V, I <sub>D</sub> =0.5 A	1	1.6	3	
Transconductance	$g_{ ext{fs}}$	$ V_{\rm DS}  > 2 I_{\rm D} R_{\rm DS(on)max},$ $I_{\rm D} = 0.24 \text{ A}$	0.2	0.36	-	S

 $<sup>^{(2)}</sup>$  Perfomed on a 40x40mm  $^2$  FR4 PCB with both sided Cu sense-force traces, each 1mm wide, 70  $\mu m$  thick and 20mm long.



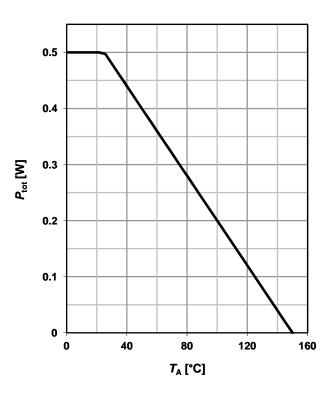
Parameter	Symbol	Symbol Conditions		Values		Unit
			min.	typ.	max.	
Dynamic characteristics						
Input capacitance	Ciss		-	13	20	pF
Output capacitance	Coss	V <sub>GS</sub> =0 V, V <sub>DS</sub> =25 V, f=1 MHz	-	4.1	6	
Reverse transfer capacitance	C <sub>rss</sub>		-	2.0	3	
Turn-on delay time	$t_{\rm d(on)}$		-	3.0	4.5	ns
Rise time	t <sub>r</sub>	V <sub>DD</sub> =30 V, V <sub>GS</sub> =10 V,	-	3.3	5	
Turn-off delay time	$t_{d(off)}$	$I_{\rm D}$ =0.5 A, $R_{\rm G}$ =6 $\Omega$	-	5.5	9	
Fall time	t <sub>f</sub>		-	3.1	5	
Gate Charge Characteristics						
Gate to source charge	Q <sub>gs</sub>	V <sub>DD</sub> =48 V, I <sub>D</sub> =0.5 A, V <sub>GS</sub> =0 to 10 V	-	0.05	0.1	nC
Gate to drain charge	Q <sub>gd</sub>		-	0.2	0.4	
Gate charge total	Qg		-	0.4	0.6	
Gate plateau voltage	V <sub>plateau</sub>		-	4.0	-	V
Reverse Diode						
Diode continous forward current	Is	T -25 °C	-	-	0.3	Α
Diode pulse current	I <sub>S,pulse</sub>	- T <sub>A</sub> =25 °C	-	-	1.2	
Diode forward voltage	V <sub>SD</sub>	V <sub>GS</sub> =0 V, I <sub>F</sub> =0.5 A, T <sub>j</sub> =25 °C	-	0.96	1.2	V
Reverse recovery time	t <sub>rr</sub>	$V_R$ =30 V, $I_F$ =0.5 A, $di_F/dt$ =100 A/ $\mu$ s	-	8.5	13	ns
Reverse recovery charge	Q <sub>rr</sub>		-	2.4	4	nC

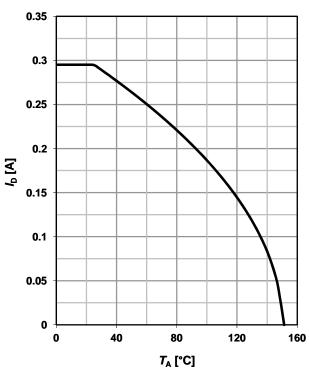


#### 1 Power dissipation

### $P_{\text{tot}} = f(T_A)$

### 2 Drain current





#### 3 Safe operating area

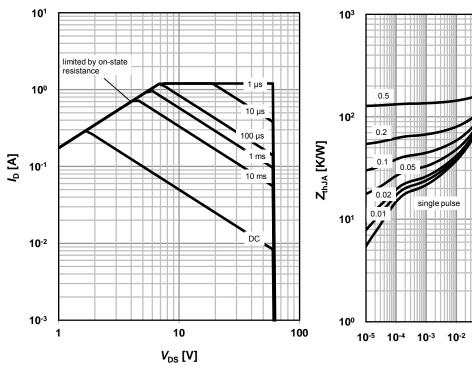
 $I_D$ =f( $V_{DS}$ );  $T_A$ =25 °C; D=0

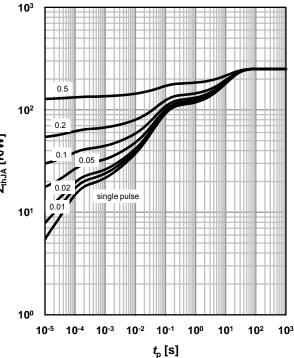
parameter:  $t_p$ 

#### 4 Max. transient thermal impedance

 $Z_{\text{thJA}}$ =f( $t_{p}$ )

parameter:  $D=t_p/T$ 



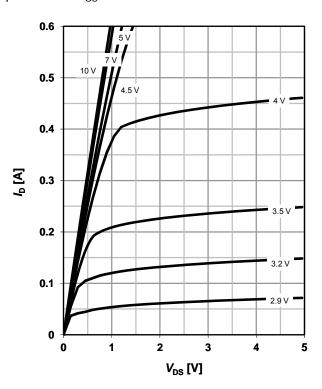


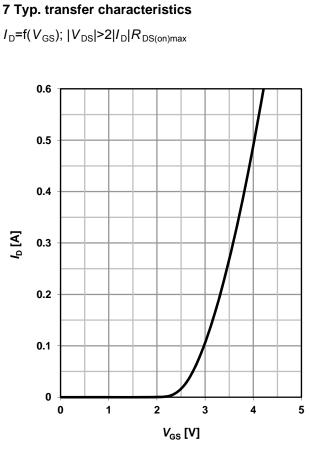


### 5 Typ. output characteristics

 $I_D = f(V_{DS}); T_i = 25 °C$ 

parameter:  $V_{\rm GS}$ 

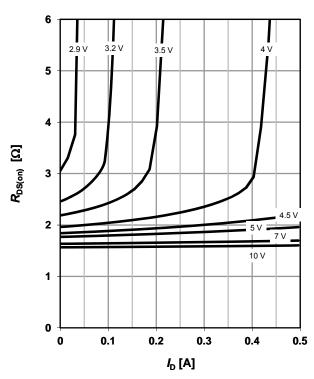




#### 6 Typ. drain-source on resistance

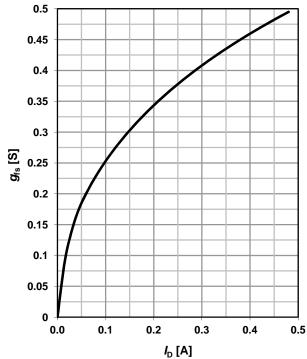
 $R_{DS(on)}=f(I_D); T_j=25 °C$ 

parameter:  $V_{\rm GS}$ 



### 8 Typ. forward transconductance

 $g_{fs}$ =f( $I_D$ );  $T_j$ =25 °C





#### 9 Drain-source on-state resistance

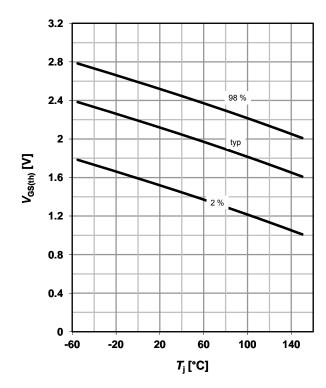
 $R_{DS(on)} = f(T_i); I_D = 0.3 A; V_{GS} = 10 V$ 

## 6.0 5.0 4.0 $R_{ extsf{DS(on)}}\left[\Omega ight]$ 3.0 2.0 1.0 0.0 -60 -20 20 60 100 140 *T*<sub>j</sub> [°C]

#### 10 Typ. gate threshold voltage

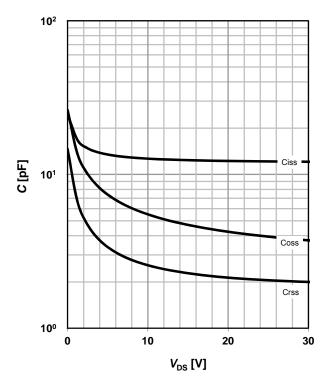
 $V_{GS(th)}$ =f( $T_j$ );  $V_{DS}$ = $V_{GS}$ ;  $I_D$ =250  $\mu$ A

parameter: I<sub>D</sub>



#### 11 Typ. capacitances

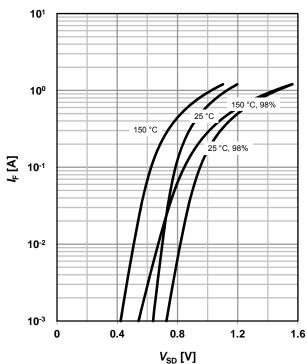
C=f( $V_{DS}$ );  $V_{GS}$ =0 V; f=1 MHz;  $T_j$ =25°C



#### 12 Forward characteristics of reverse diode

 $I_{\mathsf{F}} = \mathsf{f}(V_{\mathsf{SD}})$ 

parameter: T<sub>i</sub>

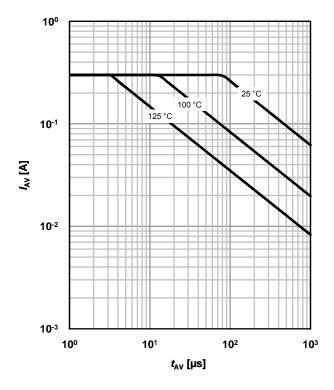




#### 13 Avalanche characteristics

 $I_{AS} = f(t_{AV}); R_{GS} = 25\Omega$ 

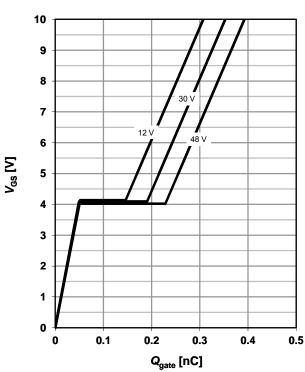
parameter: T<sub>j(start)</sub>



### 14 Typ. gate charge

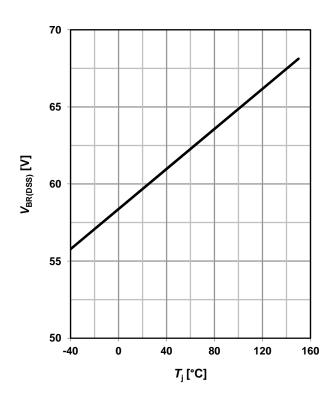
 $V_{\rm GS}$ =f( $Q_{\rm gate}$ );  $I_{\rm D}$ =0.5 A pulsed

parameter:  $V_{\rm DD}$ 



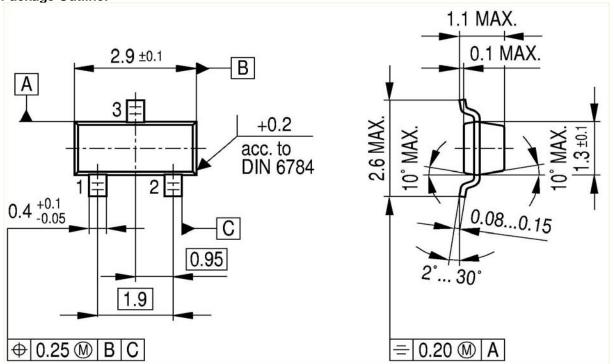
### 15 Drain-source breakdown voltage

 $V_{BR(DSS)}$ =f( $T_j$ );  $I_D$ =250  $\mu$ A

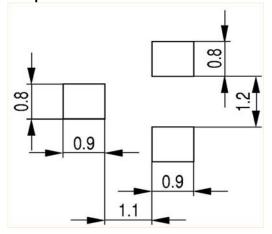




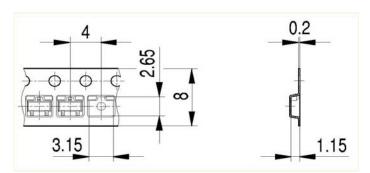
#### **Package Outline:**



#### **Footprint:**



#### Packing:





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